



Wojtek Hajdas :: LTP/ DIAPP :: Paul Scherrer Institut

# Applied Particle Physics -Irradiation Facilities for Components Testing at PSI

LTP Monday Seminar 25.06.2018



- 1. Spacecraft environments and radiation in space
  - a. European Components Irradiation Facilities
  - b. Why PSI and why protons? 1st latch-up in space
- 2. Radiation effects ...general
- 3. Radiation hardness test definition
- 4. ESA test methods / radiation hardness characterization
- 5. Effects examples from two missions: Galileo and POLAR
- 6. Space radiation environment: solar, cosmic, trapped, Jovian
- 7. Models vs. reality / example from RHESSI
- 8. PSI exposure facilities for radiation effects
  - a. Accelerators
  - b. Protons PIF
  - c. Electrons EMON
  - d. Electrons piM1
- 9. Detection system and dosimetry
  - a. Standard detector technology
  - b. New developments / Propix II (m)
  - c. PSI detectors for space RADEM (m)
- 10. Operation and users



## Spacecraft environment

## Spacecraft environment

- Pre-operational and Operational
- Launch phase
  - Vibration
  - Acoustics
  - Shock and acceleration
  - Thermal
  - Pressure
- Operational
  - Solar radiation
  - Ionizing radiation
  - Charging
  - Meteorites
  - Debris
  - Thermal
  - Earth orbit environment





## **European Components Irradiation Facilities**

## ECIF for studies of radiation effects in lab

- HIF / Belgium
- RADEF / Finland
- PIF / Switzerland
- CASE / The Netherlands

### Other European Sites:

- TSL / Uppsala / Sweden
- GANIL / France
- GSI, COSY / Germany
- AGOR / The Netherlands
- Catania





# Why PSI, why protons? 1st Latch-up in space

- Earth Resource Satellite launched in July 1991 into 784 km orbit
- The Precision Range and Range Rate Equipment shuts down 5 days later
- Reason 9W overcurrent lasting 32s; the instrument did not restart anymore
- Switch-off occurred at the South Atlantic Anomaly
- ESA, PSI (R. Henneck) and University of Stuttgart exposed PRARRE to protons at OPTIS
- System behavior confirmed and latch-up found in CMOS RAM ( at F~3·10<sup>7</sup> p/cm<sup>2</sup>! )







Radiation effects ... broad view

### **Relevant for tests at PSI**

Single Event Effects SEE

- Mostly in nuclear processes
- Critical charge
- Sensitive volume

### Displacement Damage **DD**

- Lifetime damage
- Carrier removal
- Mobility







## Radiation hardness test definition

Radiation effect	Parameter	Test means
Electronic component degradation	Total ionising dose	Radioactive sources (e.g. <sup>60</sup> Co), particle beams: electron, proton
Material degradation	Total ionising dose	Radioactive sources (e.g. <sup>60</sup> Co), particle beams: electron, proton
Material degradation (bulk damage)	Non-ionising dose (NIEL)	Proton beams
CCD and sensor degradation	Non-ionising dose (NIEL)	Proton beams
Solar cell degradation	Non-ionising dose (NIEL) & equivalent fluence.	Proton beams (~ low energy)
Single Event Effects SEE SEU, MEU, SEL, SEFI, SET, SEB, SEGR, etc	LET spectra (ions), proton energy spectra, explicit SEU/L rate.	Heavy ion particle beams Proton particle beams
Sensor interference - background signals	Flux above energy threshold, explicit background rate.	Radioactive sources, particle (e.g. proton) beams
Internal Electrostatic Charging	Electron flux, fluence dielectric E-field.	Electron beams Discharge characterisation



### ESTEC - EUROPEAN SPACE RESEARCH AND TECHNOLOGY CENTRE

### ECSS - EUROPEAN COOPERATION FOR SPACE STANDARDAZATION

• Standard documents

Radiation test specifications and procedures

ECSS-Q-ST-70-06C Annex B

Radiation test report

ECSS-Q-ST-70-06C Annex C

Request for radiation test

ECSS-Q-ST-70-06C Annex A

- Applicable documents
  - Single Event Effects Test Method and Guidelines
  - Total Dose Steady-state Irradiation Test Method
  - Radiation Design Handbook



# Example-1 of effects in space – Galileo

Galileo - NASA mission to Jupiter Launch 1989, operation 1995 – 2003 Most instruments affected by radiation Displacement Damage:

- Dark current
- Response uniformity
- Electronic chain degradation
- Sensor current consumption etc. Single Event Effects:
- Upsets
- Transients
- Latch-ups
- Stacked bits etc.

### In the meantime things just ... evaluated

<b>SYMPTOM</b>	CAUSE	FIX
Spurious signals at slip rings.	+++,1A	Reprogram software to ignore signals
Camera returns white images.	+++,1A	Drop signal input to sensitive FET.
Infrared spectrometer (NIMS)	+++,1B	Scheduled software reloads in radiation.
memory resets.		
Instrument (EPD) memory	+++,1C, 4C	Scheduled software reloads in radiation.
resets.		
Quartz oscillator frequency	+++,2A,3A	Receivers widen bandwidths.
changes.		
Spin detector signal noise	+++,2A	Reprogrammed to output a constant spin
increase.		rate determined by other means.
Gyro electronics suffer signal	+++,2B	Frequent characterization tests. Less use of
bias.		gyros.
Star Scanner sees false stars,	+++,3A	Use bright stars.
blinded.		
Visible camera (SSI) image noise.	+++,3A	Adjacent pixel averaging.
Polarimeter (PPR) signal noise.	+++,3A,1C	Strip out "impossible" values from data set.
Infrared spectrometer (NIMS)	+++,3A,1C	Hand removal of noise from data set.
signal noise.		
Dust detector (DDS) signal	+++,3A,1B	Instrument design allows noise/data
noise.	10.00	discrimination.
Voltage controlled oscillator	++,1C, 2C	Pulse current to neutralize ion drift in
Trequency jump.		electronic device.
Particle detector (EPD)	++,2B	Park detector behind nearby mass to
sensitivity loss.		provide shielding. Loss of channel in one
Spectrometer (LIVE) grating	1.1. 2D	None loss of instrument
failure	++,2 <b>D</b>	None - loss of instrument.
Photomultiplier tube (Star	++ 2B	Use bright stors, adjust predicted intensities
Scanner) gain loss	· · ,2D	Ose origin stars, adjust predicted intensities.
Camera (SSI) image compression	++ 2B	None - some forms of on-CCD
failure	,20	compression lost
S-band fr degradation in Io torus	++ 3B	De-weight data for navigation
Magnetometer processor lock-	+10.40	Scheduled power-cycles & memory reloads
up.	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	scheduled power cycles & memory reloads.
Voltage controlled oscillator	+2C	Input frequency adjusted to VCO's new base
frequency drift.	,20	frequency.
Dust detector sensitivity	+,2C	None
decrease.	,	
Analog to digital converter shift.	+,2C	None
CMOS Memory cell failures.	+,4C	Reprogram around failed cells.



## Example-2 of effects in space – POLAR

### POLAR – novel hard X-ray polarimeter (CH-CN)

- Launched in Sep 2016 on Chinese TG2
- Goal polarimetry of Gamma Ray Bursts (linked to GW)
- PSI electronics onboard: Frontends and Central Unit
- High Voltage unit lost on 31.03.2017 catastrophic failure
- Location at SAA boarder

Counts (/s)

• Reasons unclear: charging, protons ...

(see polar.psi.ch , POLAR PSI Data Center by Hualin Xiao)



chain temp



Sudden rate break with HV loss and temperature rise



Space radiation environment

### Real, dynamic, wide-ranging and costly



### **Solar Events**

Solar energetic particles

Geo-storms; particle injections

## **Trapped Radiation**

Proton belt Electron belts South Atlantic Anomaly Human made

## **Cosmic Rays**

Galactic

Anomalous

## **Jupiter Radiation Environment**

### **Hot Plasma**

Testing on ground is indispensable



## Solar flares Electron rich Lasting hours Coronal mass ejections Proton rich Lasting days

Solar energetic particles can cause doses of even ~10 krad

See e.g. srem.web.psi.ch for observations of PSI designed ESA Standard Radiation Environment Monitor SREM





### Galactic Cosmic Rays GCR

Low intensities High penetration High energies > GeV/n High LET > 10<sup>4</sup> MeV/g/cm<sup>2</sup>

### **Anomalous Cosmic Rays ACR**

Reaching tens MeV/n Weakly ionized

- GCR mainly responsible for Single Events Effects
- In longer missions also for Displacement Damage and Total Ionizing Dose effects
- ACR effects often negligible



#### GRC iron spectra behind Al-shielding



GRC LET spectra with two different ranges of elements



## Trapped protons I.

## Proton Radiation Belt and South Atlantic Anomaly SAA

- Partially responsible for Single Event Effects
- Major agent for Displacement Damage
- Energies above hundred MeV
- Shielding partly effective
- Typical doses ~ 10 rad/day
- Peak energies after shielding ~50-60 MeV
- Proton belt is relatively stable



AP8MIN omnidirectional proton flux (p/cm²/s)



Proton spectra behind Al-shielding (97° inc., 500 km)



## Trapped protons II.

## Proton Radiation Belt and South Atlantic Anomaly SAA

- SAA dominates at low altitudes and inclinations
- Caused by offset and tilt between geo-magnetic axis and Earth rotation axis
- The belt is intruding to lower altitudes
- Both protons and electrons are present
- ISS also crosses SAA (fast passage ~20%)





Magnetic field contours for 500 km altitude



TG2 Radiation monitor rate map with SAA (6.3.2017)



## **Radiation Belts:**

### inner, outer and SAA

- Major agent for total ionizing dose
- Energies up to few MeV
- Highly dynamic, sensitive to storms
- Extends behind GEO orbit
- Shielding effective (local, thin plates)
- Typical doses ~ 10 rad/day
- Causes bremsstrahlung





Electrons flux data from NOAA satellites (E>1MeV)

AE8 model omnidirectional electron flux (e/cm²/s)



## Jupiter radiation environment





## Models vs. reality / example from RHESSI

### **ECSS Standard models**

- AE8 trapped electrons
- AP8 trapped proton

Static, isotropic models based on limited dataset for solar minimum and maximum
Not suited for low altitude and inclination
ESA estimated accuracy at factor of 2-3

### New development – AE9 and AP9

- with uncertainties and errors in data
- based on probabilities with Monte Carlo Tend to predict higher fluxes than AP8/AE8



Comparison of AX8 and AX9 models for LEO orbit



Electron rate in RHESSI monitor vs. rotation angle



# PSI exposure facilities for radiation effect studies

- Proton Irradiation Facility operates continuously since 1992
- Connected to COMET cyclotron of the Proton Therapy Center
- Priorities given by patient exposure plan
- Other exposure sides and particles are also utilized:
  - piM1 secondary beam area with electrons, pions and protons
  - Electron mono-chromator with monoenergetic electrons from beta sources

- Main functions:
  - User-lab for radiation effects studies in electronics
  - Realistic simulator of space radiation environment
  - Source of mono-energetic particles for rad-tests
  - Calibration station for monitors and detectors
  - Radiation qualification for space technologies



NA area with COMET cyclotron and exposure sites



# **COMET Compact Medical Therapy Cyclotron**

- Facility of the PSI Proton Therapy Center
- Designer H. Blosser, MSU/USA
- Delivered by VARIAN
- 250 MeV fixed energy
- Mass 90 tons
- Intensity range 0-1000 nA
- In operation since 2007







# **Proton Irradiation Facility**

- Initial energies: 230, 200, 150, 100, 74 MeV
- Energies after degrader: 230 MeV to 6 MeV
- Max intensity: 2 nA (E>200) 10 nA (E<100)
- Flux range  $10^2 2 \cdot 10^8$  p/sec/cm<sup>2</sup>
- Profiles Gaussian-like: FWHM 9 cm
- Max beam diameter of 90 mm
- Options: focused (6 mm  $\phi$ ) or flat beam
- User adapted dosimetry and test flow
- Standard calibrations runs and checks / fluxes, profiles, scaling









## Electron monochromator

- Simple bending magnet and strong electron source in large vacuum chamber
- Flux control system constructed; Si-detector with dedicated DAQ
- XY-table with remote sample control; support with TV cameras and illumination
- Two units:
  - PSI
  - ESTEC



Si-sensor and DAQ system (left) Monochromator chamber (right)



Intensity curve for <sup>90</sup>Sr source; Sidetector 2 cm from beam exit



High energy electrons in piM1 I.

- Adapting secondary beam area piM1 of PSI large cyclotron
- Positive and negative particles possible
- Clean electrons beams from about 10 MeV up to 100 MeV
- Protons available up to 70 MeV
- Pions and muons from 100 MeV/c to 350 MeV/c



piM1 Test area: beam exit and PIP-JUICE setup



Beam contamination level as function of momentum



## High energy electrons in piM1 II.

- Typical intensities:  $2 \cdot 10^5 1 \cdot 10^7$  /s and fluxes:  $2 \cdot 10^3 5 \cdot 10^5$  /cm<sup>2</sup>/s
- FWHM between 4 cm and 10 cm
- Well suited for studies of instrument shielding and calibration
- Too low fluxes for TID tests; other test areas studied

Momentum MeV/c	Intensity s/mA	Flux cm2/s/mA	FWHMx cm	FWHMy cm
17.3	1.16E+05	7.21E+02	10.4	13.2
23.0	3.28E+05	2.57E+03	9.0	12.9
34.5	1.16E+06	1.56E+04	6.6	9.6
57.5	3.08E+06	7.88E+04	5.2	6.6
86.3	5.13E+06	1.69E+05	4.2	5.1
115.0	5.18E+06	2.42E+05	4.4	4.3

#### Electron beam parameters in piM1 area.



Electron flux vs. momentum



## Detector technology and dosimetry

- Plastic or Silicon detector to calibrate the beam
- Real time dosimetry uses two ionization chambers IC
- Profiles are measured with pixelated IC, plastic scans or luminescence foils





# Dosimetry I. ESA SEU Monitor

- Developed in 2005 by R.H. Sorensen (ESA-ESTEC) and HIREX
- Based on ATMEL AT60166F 16Mbit SRAM, version 2009
- Carefully calibrated at ESA facilities; tens of units at different test sites
- Easy comparison of measured and expected flux values







# Dosimetry II. new PIF pixel ionization chamber

- Standard ionization chamber components
- Sensitive, improved readout electronics
- Easy data acquisition system
- Easy setup and operation
- Fast beam profiling
- Very wide dynamic range













# Dosimetry II. new PIF pixel ionization chamber

- Standard ionization chamber components
- Sensitive, improved readout electronics
- Easy data acquisition system
- Easy setup and operation
- Fast beam profiling
- Very wide dynamic range











## Detector technology I. RADEM for ESA JUICE

#### **Radiation Hard Electron Monitor RADEM**

Electron energy range	0.3 - 40 MeV
Proton energy range	5 - 250 MeV
Energy resolution	8 log bins for e and p
Peak flux	10 <sup>9</sup> /cm <sup>2</sup> s <sup>1</sup>
lon sensitivity	LET 0.1-10 MeV/(mg/cm
Directionality	31 directions; $\Delta \Theta$ =±75°
Mass; Volume	~ 4 kg; 1000 cm <sup>3</sup>
Power; Temperature	$\sim$ 4 W; -30/+50 $^{\circ}$ C
Lifetime	11 years
Dedicated readout ASIC	VATA466

RADEM EM currently at PSI for particle tests Final delivery – December 2019













## Detector technology II. RADEM for ESA JUICE











## Detector technology II. RADEM for ESA JUICE





PAUL SCHERRER INSTITUT







RIME antenna PEP/NU PEP/JENI RADEM RIME/Matching network SAS +Z



## Operation and users I.

- Operation: weekends and nights; usually 2-3weekends/month
- Flexible, user-specific test arrangement
- Fast, uncomplicated set-up and operation
- Automated irradiations
- Standard sample frame (as at HIF, RADEF and Brookhaven)
- Irradiation usually in air
- Typical laboratory apparatus available (also vacuum chambers)

Shifts	> 200
Number of tests	- 91
Institutions	- 29
Users	- 160
ESA related shifts	- 142
ESA pool shift	- 30

Statistics for 2017



## Operation and users II.



Institution	Project	Davs	Start	Stop	Shifts	ESA Project	ESA Pool
PSI	Maintenance services of the proton and electron facility	3	18.1	20.1	3	Y	N
PSI	Test of beam setup and beams after winter shutdown	2	22.1	23.1	1.5	Y	Y
PSI	Maintenance services of the electron facility	1	22.1	22.1	1.5	Y	N
E2V	DD and TID tests of new CCDS	2	29.1	30.1	1	Y	N
Spacetech	Tests of components for MERLIN mission / TID and DD	2	3.2	4.2	2	Y	N
PSI	Test and operation of new camera	2	2.2	3.2	1	Y	Y
ESA	Test of OpAmps and transients	2	4.2	5.2	3	Y	Y
E2V	Various optical sensors exposures	2	10.2	11.2	1.5	Y	N
PSI-EFACEC-LIP	Measurements of active area of the RADEM Directionality Sensor	1	11.2	11.2	2	Y	N
Open University	Exposure and tests of optical sensors from E2V	1	12.2	12.2	2	Y	N
CERN	Beamline dosimetry electronics	3	16.2	18.2	5	N	N
E2V	Irradiations of CCDs	2	24.2	25.2	2	Y	N
Haute-Ecole Arc	Irradiations of CubeSat components	2	25.2	26.2	2	Y	N
ESA, TRAD	Tests of various SEE components	2	3.3	4.3	3	Y	Y
Thales-Alenia	Test and calibration of NGRM EM / noise, thresholds, responses	3	1.3	4.3	3	Y	N
Thales-Alenia	Test and calibration of NGRM EM/ angles, area and deadtime	2	5.3	6.3	2	Y	N
ETHZ	testing of NEO-M8T GNSS receiver	1	15.3	15.3	2	Y	N
E2V	Exposure and tests of optical sensors from E2V	1	18.3	18.3	2	Y	N
CERN	Beamline dosimetry electronics	2	25.3	26.3	4	N	N
EFACEC-PSI-LIP	Characterization of RADE/JUICE diodes / area, sensitivity	2	1.3	2.3	2	Y	N
PSI-EFACEC-LIP	Tests of active area of DD sensor (signal line contribution) / RADEM	1	22.3	22.3	2	Y	N
Thales-Alenia	Test and calibration of NGRM EM /with electrons	1	23.3	23.3	2	Y	N
EASII	Tests of various Radio Frequency components SEE/SET sensitivity	2	1.4	2.4	2	N	N
Tsinghue University, PSI	TID/ DD characterization of CASCA ASIC	2	6.4	7.4	1.5	N	N
Thales-Alenia	Calibration of NGRM EM/ accurate deadtime tests	2	7.4	8.4	2	Y	N
CERN	Beamline dosimetry electronics	2	22.4	23.4	4	N	N
ESA, Uni Montpellier, ESCC, JPL	Tests of various CubeSat components	1	28.4	28.4	3	Y	Y
E2V	Optical devices for Flex project	1	30.4	30.4	1	Y	N
PSI, ESCC and Uni Montpellier	Characterization of beam / retest of beam settings	1	30.4	30.4	1	Y	N
PSI	Test of proton beams at 350 and 372 MeV/c at PiM1 area	1	10.5	10.5	1	Y	Y
Tsinghue University, PSI	Beam optimization for CASCA ASIC SEE tests at piM1	1	21.5	21.5	1	N	N
E2V	Tests of optical sensors at PiM1	2	22.5	23.5	3	Y	N
Tsinghue University, PSI	SEE tests of the CASCA ASIC at PiM1	2	23.5	24.5	3	N	N
PSI	Test of electron beams between 20 and 350 MeV/c at PiM1	1	24.5	24.5	2	Y	Y
PSI-EFACEC-LIP	Proton tests of RADEM BB DD with ASIC VATA466 at PiM1	2	25.5	26.5	2	Y	N
PSI-EFACEC-LIP	Electron test of RADEM BB DD with ASIC VATA466 at PiM1	1	27.5	27.5	1.5	Y	N
PSI-EFACEC-LIP	RADEM BB DD ASIC and detector test with electrons from EMON	2	28.5	31.5	3	Y	N
Thales-Alenia	NGRM EQM, test of electron discrimination in EDSS and SDSS	2	29.5	30.5	3	Y	N
PSI-EFACEC-LIP	RADEM BB DD ASIC and detector test with electrons from EMON	2	1.6	2.6	2	Y	N
PSI	Beam tests and verification of system after upgrade	2	28.6	30.6	2	Y	Y
Tshinghua University / PSI	Test of cAScA ASIc	2	1.7	2.7	2	N	N
ESA ESTEC	Tests of optical transceivers	3	7.7	9.7	4.5	Y	Y
CERN	Various dosimetry electronics tests	3	14.7	16.7	5	N	N
EASII	Test of various IC	2	21.7	22.7	2	N	N
PSI/ PIF	Software and hardware optyimization fo rdosimetry	1	22.7	22.7	1	Y	Y
EASII	Test of various IC	1	23.7	23.7	2	N	N
PSI/ PIF	Optimization of beam dosimetry and camera installation	1	28.7	28.7	1	Y	Y
PSI / LIP / EFACEC	RADEM EM tests of SI-diodes energy resolution	3	10.7	12.7	3	Y	N
PSI	piM1 tests of electron beams	2	25.8	28.8	3	N	N
Xiniiang Institute of CAS	Xiniiang Institute of CAS	3	26.8	28.8	1.5	N	N
Tsinghua Universit / PSI	Further tests of CASCA ASIC sensitivity to neutrons	1	27.8	27.8	1.5	N	N
Xinjiang Institute of CAS	Xinjiang Institute of CAS / continuation	1	28.8	28.8	1.5	N	N
PSI / LIP / EFACEC	RADEM FM diodes electronic resolution tests	1	2.8	2.8	1.5	Y	N
PSI / LIP / EFACEC	RADEM FM diodes electronic resolution tests	1	4.8	4.8	1.5	Y	N
PSI / LIP / EFACEC	RADEM FM diodes electronic resolution tests	2	17.8	18.8	2.5	Y	N
PSI / LIP / EFACEC	RADEM FM diodes electronic resolution tests	1	28.8	28.8	1.5	Y	N
PSI	Replacement of IC chamber and new Plastic detector tests	1	23.8	23.8	1	Y	Y
INTA	Tests of microcontrollers	2	1.9	2.9	2	Y	N
PSI	Electron beam tests at PiM1	2	1.9	5.9	2	N	N
PSI	Test of various optical sensors	4	13.9	16.9	4	N	N
SkyLab	Test of ProASIC3 FPGA	1	16.9	16.9	2	Y	N
AIRBUS	Test of transient events in flash memories	1	30.9	30.9	2	Y	N
PSI / LIP / EFACEC	RADEM FM diodes electronic resolution re-tests	2	6.9	8.9	2	Y	N
PSI / LIP / EFACEC	RADEM FM diodes electronic resolution re-tests (3 mm diam)	1	11.9	11.9	1.5	Y	N
PSI / LIP / EFACEC	RADEM FM Si-diodees recheck and retest of electronic resolution	2	28.9	29.9	2	Y	N
AIRBUS	Radiation characterization of flash memories	2	1.10	2.10	2	Y	N
EASII	Test of various components	3	6.10	8.10	4	Y	N
E2V-Teledyne	DD and TID tests of new CCDS	2	8.10	9.10	2	Y	N
TRAD	Radiation characterization of flash memories	3	14.10	16.10	6	Y	N
PSI	Tests of SI-PMTs	1	28.10	28.10	1	N	N
PSI	Beam optimization and calibration for RADEM / JUICE	1	29.10	29.10	1	Y	N
EFACEC-PSI-LIP	First calibration of RADEM EM	2	30.10	31.10	3	Y	N
Seibersdorf Lab	TPC and absorbers tests	2	3.11	4.11	2.5	Y	Y
HIREX	Test of various components for ESA projects	3	4.11	6.11	4.5	Y	Y
E2V-Teledyne	Test of various optical sensors	2	9.11	10.11	2	Y	N
CERN	Test of various parts for beam line dosimetry	2	10.11	11.11	4	N	N
PSI	Test of new SW and Plastic deetector automated beam scanner	2	17.11	18.11	2	Y	N
PSI	Beam pre-calibration for EASII	1	18.11	18.11	0.5	Y	N
ESA / NANOEXPLORE	Test of BRAVE FPGA	2	18.10	19.10	4	Y	Y
PSI / LIP / EFACEC	Test of focused beams for acceerated DD tests	1	20.11	20.11	1	Y	N
EASII / ST	Test of new memory types and test structures	2	22.11	23.11	3	Y	N
ESA / SITAEL	OBM, TMTC PCBs for spacecraft platforms	2	25.11	26.11	4.5	Y	Y
E2V-Teledyne	Test of optical sensors for PLATO mission	2	26.11	27.11	1	Y	N
Surrey Satellite Technologies	Test of various integrated circuits	1	30.11	30.11	2	Y	N
CERN	Test of various components for LHC accelerator	3	1.12	3.12	4	N	N
Surrey Satellite Technologies	Test of various integrated circuits for TID and SEL effects	1	3.12	3.12	1	N	N
E2V-Teledyne	Test of optical parts for Euclid mission	2	3.12	4.12	2	Y	N
PSI / CERN and E2V-Teledyne	Pre-calibartions of beam (tests congestions)	1	14.12	14.12	1	N	0
CERN	Test of various parts for beam line dosimetry	3	15.12	17.12	4	N	0
E2V-Teledyne	Test of optical sensors for MTG and Flex	2	17.12	18.12	1	Y	N
DEI	test of new pixelated inrization chamber (PROPIX upgrade)	1	19.1	19.1	1	Y	Y

91



## Wir schaffen Wissen – heute für morgen

